

Search Notes

Application/Control No.

10/668,881

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

GORRELL ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E21.504, 778, 786 and 729	3/26/2006	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	3/26/2006	C.C.